

Search Notes

Application/Control No.

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Examiner

Helen C. Kwok

Applicant(s)/Patent under
Reexamination

NICU ET AL.

Art Unit

2856

SEARCHED

Class	Subclass	Date	Examiner
73	504.02	6/16/2006	HK
73	504.04	6/16/2006	HK
73	504.12	6/16/2006	HK
73	504.16	6/16/2006	HK
73	504.14	6/16/2006	HK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR